Sear	ch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,467	OKUYAMA ET AL.
Examiner	Art Unit

Monica Lewis

2822

SEARCHED					
Class	Subclass	Date	Examiner		
257	79-103	5/29/2005	ML		
		-			
	<u> </u>				
			_		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				
-				

5/29/2005 5/29/2005	EXMR ML
5/29/2005	MI
5/29/2005	ML
_	